

Search Notes

Application/Control No.

10/686,742

Examiner

Jean E. Lesperance

Applicant(s)/Patent under
Reexamination

MIYAKAWA ET AL.

Art Unit

2674

SEARCHED

Class	Subclass	Date	Examiner
345	36	11/3/2005	JL
345	45	11/3/2005	JL
345	46	11/3/2005	JL
345	55	11/3/2005	JL
345	76	11/3/2005	JL
345	82	11/3/2005	JL
345	84	11/3/2005	JL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PGPUB	search	11/3/2005	JL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East, inventor and PGPub searches and copy attached.	11/3/2005	JL
Consulted with Xiao Wu (primary examiner 2674)	11/2/2005	JL